

# IRF634B/IRFS634B

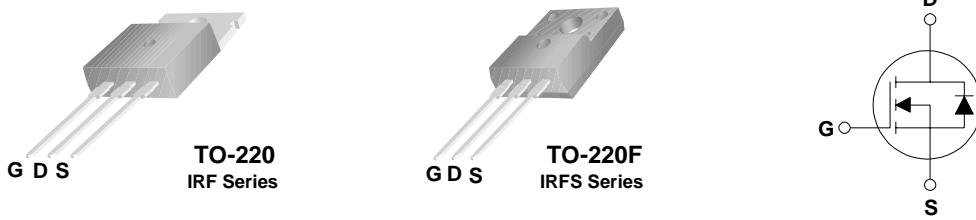
## 250V N-Channel MOSFET

### General Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar, DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switching DC/DC converters and switch mode power supplies.

### Features

- 8.1A, 250V,  $R_{DS(on)} = 0.45\Omega$  @  $V_{GS} = 10$  V
- Low gate charge ( typical 29 nC)
- Low  $C_{RSS}$  ( typical 20 pF)
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



### Absolute Maximum Ratings

$T_C = 25^\circ\text{C}$  unless otherwise noted

Symbol	Parameter	IRF634B	IRFS634B	Units
$V_{DSS}$	Drain-Source Voltage	250		V
$I_D$	Drain Current - Continuous ( $T_C = 25^\circ\text{C}$ )	8.1	8.1 *	A
	- Continuous ( $T_C = 100^\circ\text{C}$ )	5.1	5.1 *	A
$I_{DM}$	Drain Current - Pulsed	(Note 1)	32.4	A
$V_{GSS}$	Gate-Source Voltage		$\pm 30$	V
$E_{AS}$	Single Pulsed Avalanche Energy	(Note 2)	200	mJ
$I_{AR}$	Avalanche Current	(Note 1)	8.1	A
$E_{AR}$	Repetitive Avalanche Energy	(Note 1)	7.4	mJ
$dv/dt$	Peak Diode Recovery $dv/dt$	(Note 3)	5.5	V/ns
$P_D$	Power Dissipation ( $T_C = 25^\circ\text{C}$ )	74	38	W
	- Derate above $25^\circ\text{C}$	0.59	0.3	W/ $^\circ\text{C}$
$T_J, T_{STG}$	Operating and Storage Temperature Range		-55 to +150	$^\circ\text{C}$
$T_L$	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	$^\circ\text{C}$

\* Drain current limited by maximum junction temperature.

### Thermal Characteristics

Symbol	Parameter	IRF634B	IRFS634B	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case Max.	1.69	3.29	$^\circ\text{C}/\text{W}$
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink Typ.	0.5	--	$^\circ\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient Max.	62.5	62.5	$^\circ\text{C}/\text{W}$

## Electrical Characteristics

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
<b>Off Characteristics</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	250	--	--	V
$\Delta BV_{DSS} / \Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu\text{A}$ , Referenced to 25°C	--	0.27	--	V/°C
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 250 \text{ V}, V_{GS} = 0 \text{ V}$	--	--	10	$\mu\text{A}$
		$V_{DS} = 200 \text{ V}, T_C = 125^\circ\text{C}$	--	--	100	$\mu\text{A}$
$I_{GSSF}$	Gate-Body Leakage Current, Forward	$V_{GS} = 30 \text{ V}, V_{DS} = 0 \text{ V}$	--	--	100	nA
$I_{GSSR}$	Gate-Body Leakage Current, Reverse	$V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$	--	--	-100	nA

## On Characteristics

$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$	2.0	--	4.0	V
$R_{DS(\text{on})}$	Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V}, I_D = 4.05 \text{ A}$	--	0.345	0.45	$\Omega$
$g_{FS}$	Forward Transconductance	$V_{DS} = 40 \text{ V}, I_D = 4.05 \text{ A}$ (Note 4)	--	7.6	--	S

## Dynamic Characteristics

$C_{iss}$	Input Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V}, f = 1.0 \text{ MHz}$	--	780	1000	pF
$C_{oss}$	Output Capacitance		--	95	125	pF
$C_{rss}$	Reverse Transfer Capacitance		--	20	25	pF

## Switching Characteristics

$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = 125 \text{ V}, I_D = 8.1 \text{ A}, R_G = 25 \Omega$ (Note 4, 5)	--	15	40	ns
$t_r$	Turn-On Rise Time		--	75	160	ns
$t_{d(off)}$	Turn-Off Delay Time		--	100	210	ns
$t_f$	Turn-Off Fall Time		--	65	140	ns
$Q_g$	Total Gate Charge	$V_{DS} = 200 \text{ V}, I_D = 8.1 \text{ A}, V_{GS} = 10 \text{ V}$ (Note 4, 5)	--	29	38	nC
$Q_{gs}$	Gate-Source Charge		--	4.2	--	nC
$Q_{gd}$	Gate-Drain Charge		--	14	--	nC

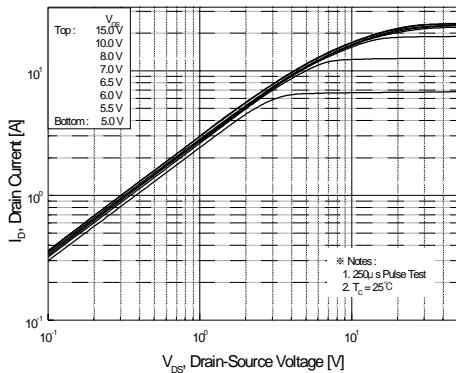
## Drain-Source Diode Characteristics and Maximum Ratings

$I_S$	Maximum Continuous Drain-Source Diode Forward Current	--	--	8.1	A	
$I_{SM}$	Maximum Pulsed Drain-Source Diode Forward Current	--	--	32.4	A	
$V_{SD}$	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = 8.1 \text{ A}$	--	--	1.5	V
$t_{rr}$	Reverse Recovery Time	$V_{GS} = 0 \text{ V}, I_S = 8.1 \text{ A}, dI_F / dt = 100 \text{ A}/\mu\text{s}$ (Note 4)	--	170	--	ns
$Q_{rr}$	Reverse Recovery Charge		--	0.91	--	$\mu\text{C}$

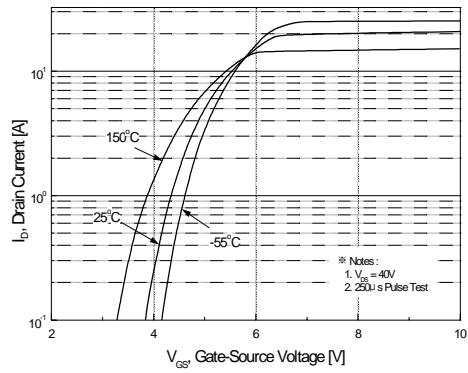
### Notes:

1. Repetitive Rating : Pulse width limited by maximum junction temperature
2.  $L = 4.9\text{mH}, I_{AS} = 8.1\text{A}, V_{DD} = 50\text{V}, R_G = 25 \Omega$ , Starting  $T_J = 25^\circ\text{C}$
3.  $I_{SD} \leq 8.1\text{A}, dI/dt \leq 300\text{A}/\mu\text{s}, V_{DD} \leq BV_{DSS}$ , Starting  $T_J = 25^\circ\text{C}$
4. Pulse Test : Pulse width  $\leq 300\mu\text{s}$ , Duty cycle  $\leq 2\%$
5. Essentially independent of operating temperature

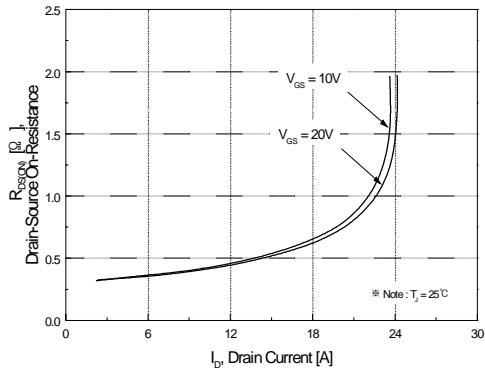
## Typical Characteristics



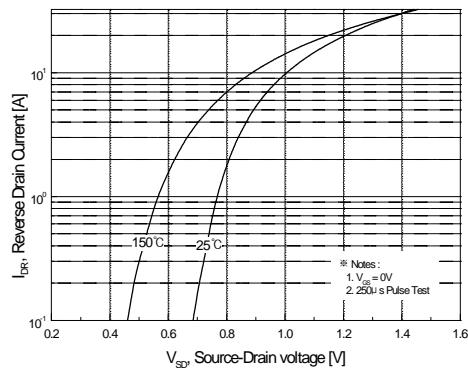
**Figure 1. On-Region Characteristics**



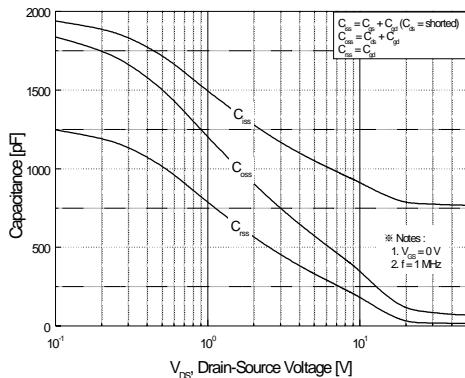
**Figure 2. Transfer Characteristics**



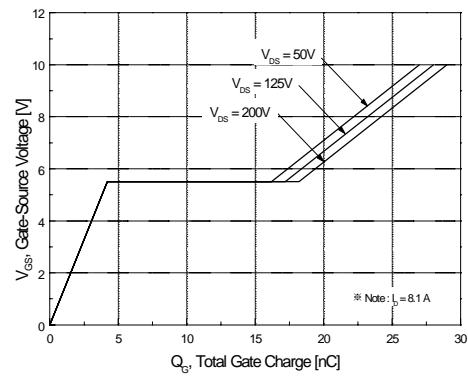
**Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage**



**Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature**

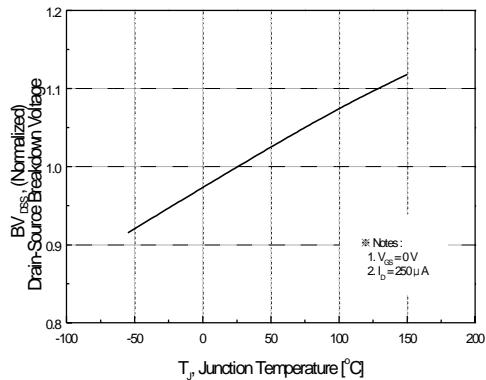


**Figure 5. Capacitance Characteristics**

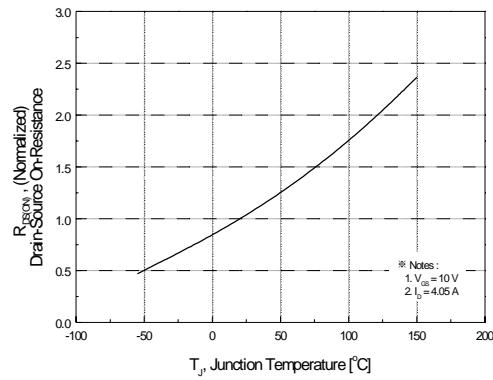


**Figure 6. Gate Charge Characteristics**

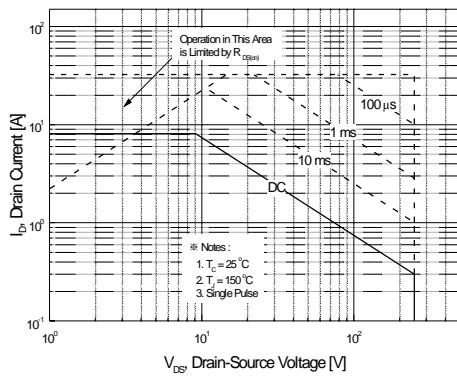
## Typical Characteristics



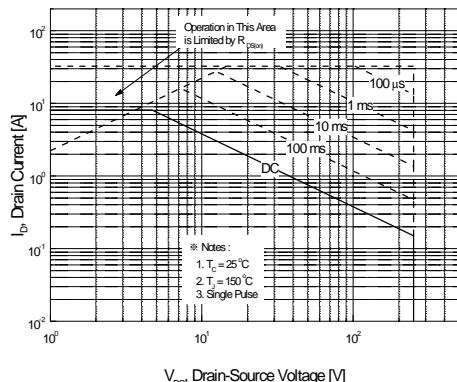
**Figure 7. Breakdown Voltage Variation  
vs Temperature**



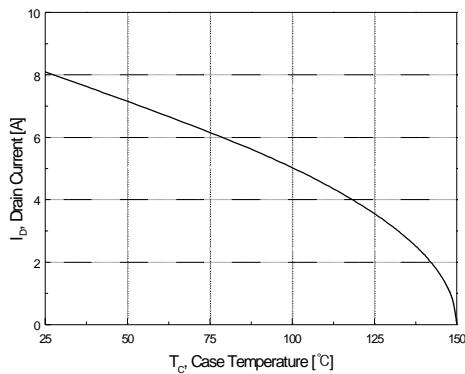
**Figure 8. On-Resistance Variation  
vs Temperature**



**Figure 9-1. Maximum Safe Operating Area  
for IRF634B**



**Figure 9-2. Maximum Safe Operating Area  
for IRFS634B**



**Figure 10. Maximum Drain Current  
vs Case Temperature**

## Typical Characteristics

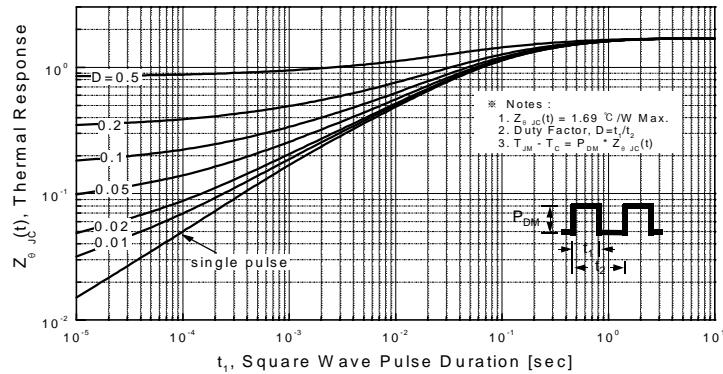


Figure 11-1. Transient Thermal Response Curve for IRF634B

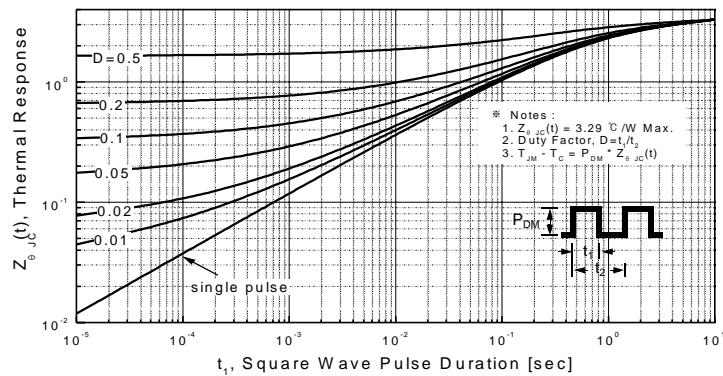
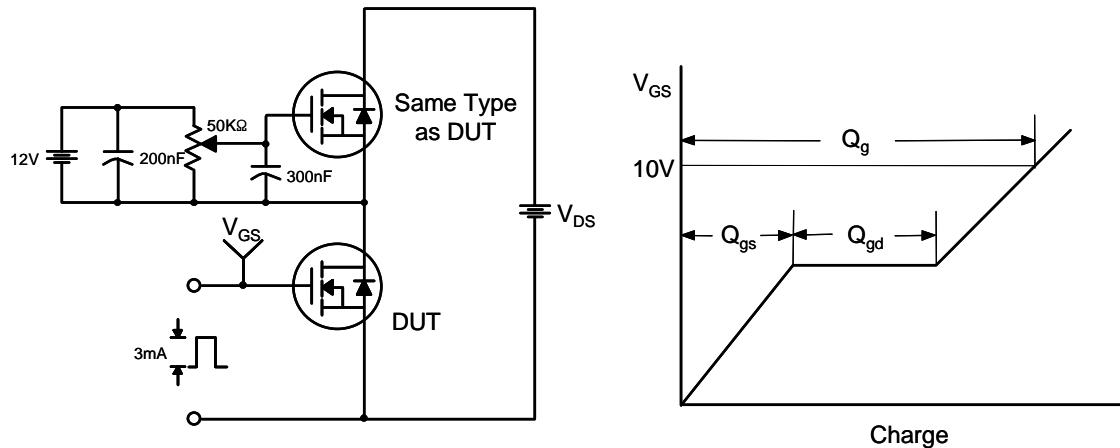
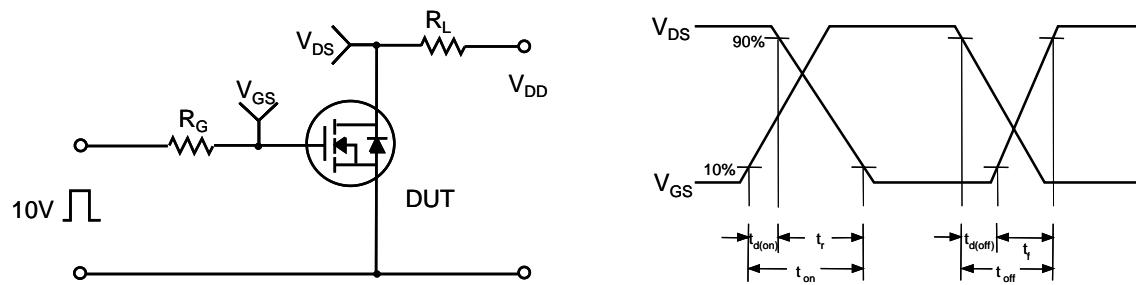


Figure 11-2. Transient Thermal Response Curve for IRFS634B

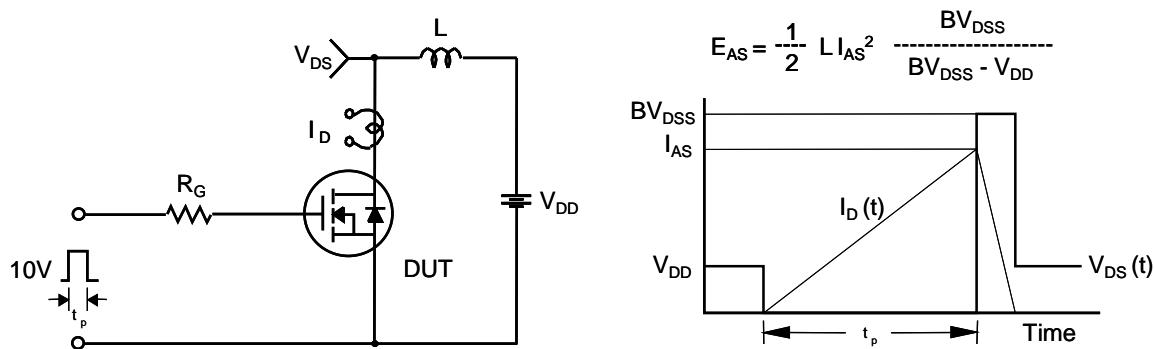
### Gate Charge Test Circuit & Waveform



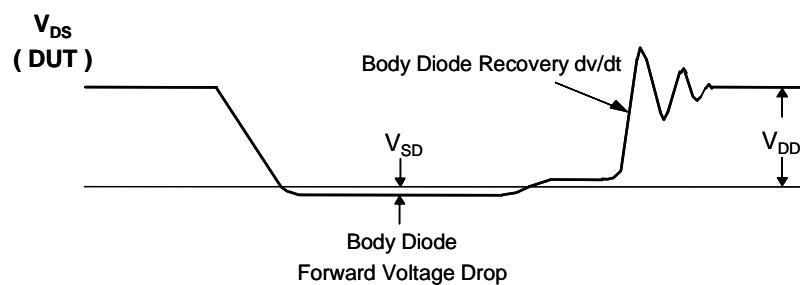
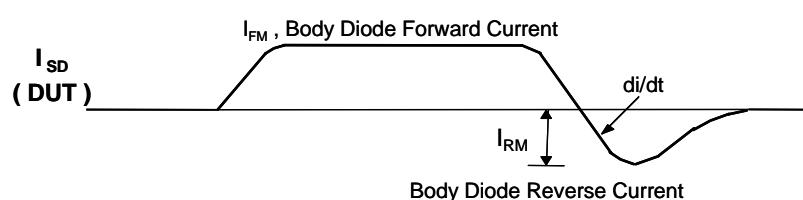
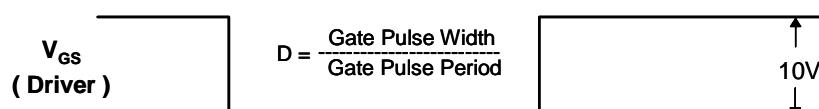
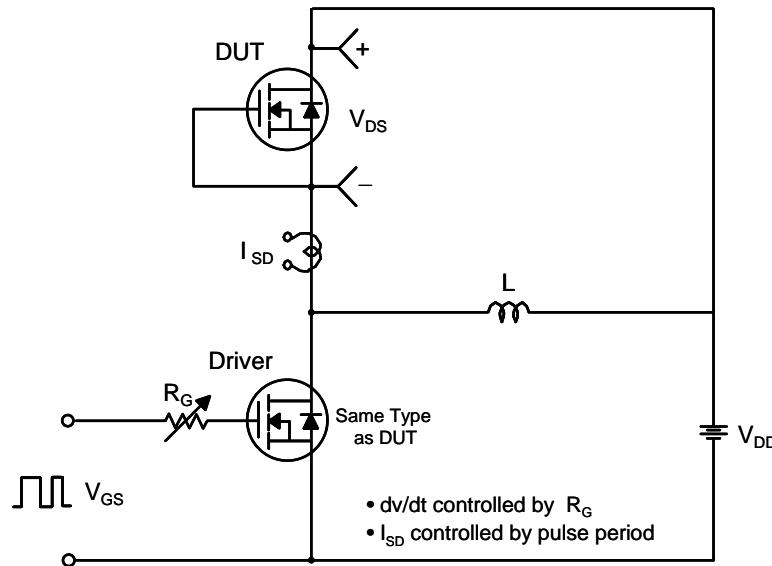
### Resistive Switching Test Circuit & Waveforms



### Unclamped Inductive Switching Test Circuit & Waveforms

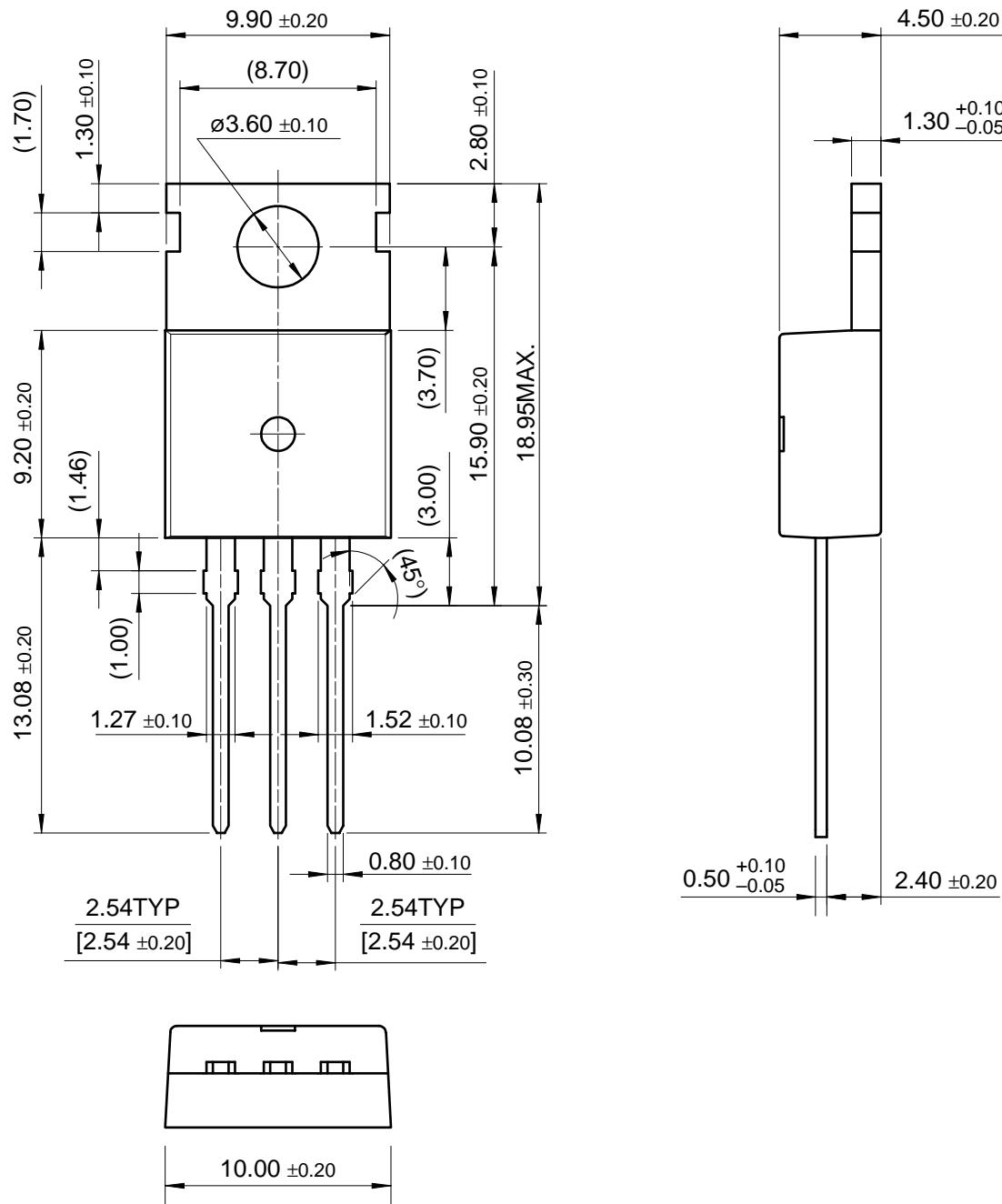


## Peak Diode Recovery dv/dt Test Circuit &amp; Waveforms



## Package Dimensions

TO-220



## Package Dimensions

TO-220F

